

## UT32N10H

Power MOSFET

32A, 100V N-CHANNEL  
POWER MOSFET

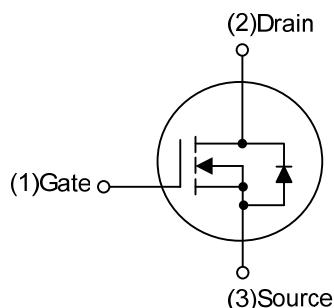
## ■ DESCRIPTION

The UTC **UT32N10H** is a N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

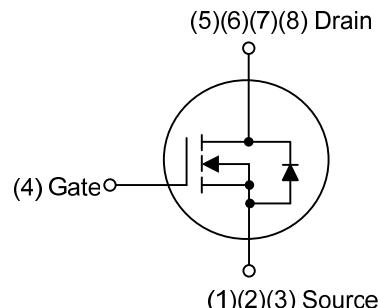
## ■ FEATURES

- \*  $R_{DS(ON)} \leq 22 \text{ m}\Omega$  @  $V_{GS}=10\text{V}$ ,  $I_D=16\text{A}$
- \* Improved dv/dt capability
- \* High Switching Speed
- \* Fast switching

## ■ SYMBOL



TO-220/TO-252

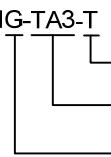


PDFN5x6

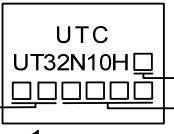
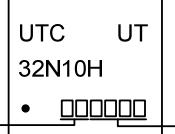
## ■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
UT32N10HL-TA3-T	UT32N10HG-TA3-T	TO-220	G	D	S	-	-	-	-	-	Tube
UT32N10HL-TN3-R	UT32N10HG-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
UT32N10HL-P5060-R	UT32N10HG-P5060-R	PDFN5x6	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: Source G: Gate D: Drain

UT32N10HG-TA3-T 	(1) Packing Type (2) Package Type (3) Green Package (1) T: Tube, R: Tape Reel (2) TA3: TO-220, TN3: TO-252, P5060: PDFN5x6 (3) G: Halogen Free and Lead Free, L: Lead Free
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### ■ MARKING

TO-220 / TO-252	PDFN5×6
 <p>L: Lead Free G: Halogen Free</p> <p>Lot Code ← Date Code</p> <p>1</p>	 <p>UTC      UT 32N10H •      日期代码 Lot Code ← Date Code</p>

■ ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	100	V
Gate-Source Voltage		$V_{GSS}$	$\pm 20$	V
Drain Current	Continuous ( $V_{GS}=10\text{V}$ )	$I_D$	32	A
	Pulsed (Note 2)	$I_{DM}$	64	A
Avalanche Energy	Single Pulsed (Note 3)	$E_{AS}$	16	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	14	V/ns
Power Dissipation	TO-220	$P_D$	100	W
	TO-252		46	W
	PDFN5×6		36	W
Junction Temperature		$T_J$	+150	$^\circ\text{C}$
Storage Temperature		$T_{STG}$	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3.  $L = 0.1\text{mH}$ ,  $I_{AS} = 18\text{A}$ ,  $V_{DD} = 25\text{V}$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$

4.  $I_{SD} \leq 30\text{A}$ ,  $di/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220	$\theta_{JA}$	62.5	$^\circ\text{C/W}$
	TO-252		110	$^\circ\text{C/W}$
	PDFN5×6		65	$^\circ\text{C/W}$
Junction to Case	TO-220	$\theta_{JC}$	1.25	$^\circ\text{C/W}$
	TO-252		2.71 (Note)	$^\circ\text{C/W}$
	PDFN5×6		3.47 (Note)	$^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

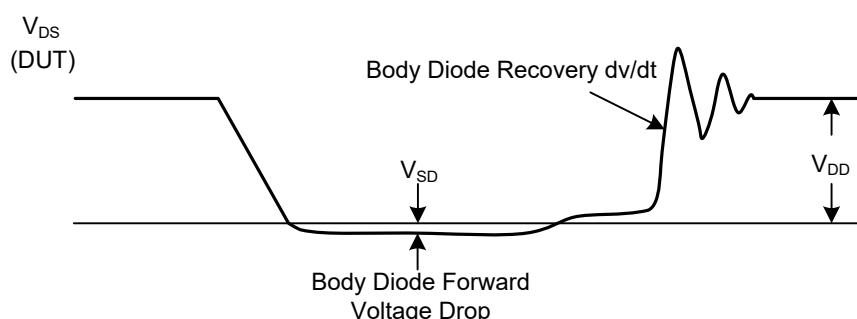
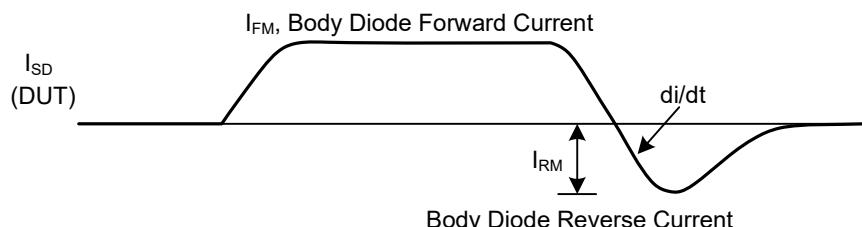
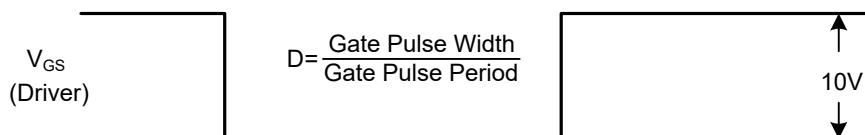
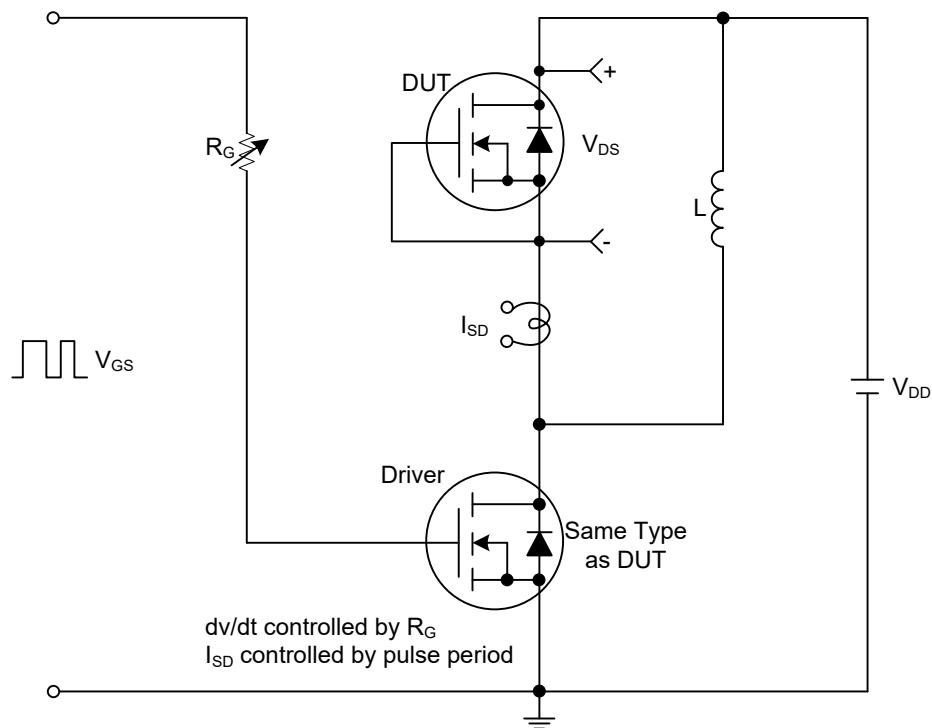
■ ELECTRICAL CHARACTERISTICS ( $T_J=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100			V
Drain-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$		1		$\mu\text{A}$
Gate- Source Leakage Current	Forward	$V_{\text{GS}}=+20\text{V}, V_{\text{DS}}=0\text{V}$			+100	nA
	Reverse				-100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{\text{GS}(\text{TH})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=16\text{A}$			22	$\text{m}\Omega$
<b>DYNAMIC PARAMETERS</b>						
Input Capacitance	$C_{\text{ISS}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1.0\text{MHz}$		2320		pF
Output Capacitance	$C_{\text{OSS}}$			183		pF
Reverse Transfer Capacitance	$C_{\text{RSS}}$			150		pF
<b>SWITCHING PARAMETERS</b>						
Total Gate Charge	$Q_G$	$V_{\text{DS}}=80\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=32\text{A}$ (Note 2)		85		nC
Gate to Source Charge	$Q_{\text{GS}}$			24		nC
Gate to Drain Charge	$Q_{\text{GD}}$			35		nC
Turn-ON Delay Time	$t_{\text{D}(\text{ON})}$	$V_{\text{DD}}=50\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=32\text{A},$ $R_{\text{G}}=3.3\Omega$ , (Note 2)		14		ns
Rise Time	$t_R$			20		ns
Turn-OFF Delay Time	$t_{\text{D}(\text{OFF})}$			38		ns
Fall-Time	$t_F$			20		ns
<b>SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS</b>						
Maximum Continuous Drain-Source Diode Forward Current	$I_S$				32	A
Maximum Pulsed Drain-Source Diode Forward Current	$I_{\text{SM}}$				64	A
Drain-Source Diode Forward Voltage	$V_{\text{SD}}$	$I_S=32\text{A}, V_{\text{GS}}=0\text{V}$			1.4	V
Body Diode Reverse Recovery Time	$t_{\text{rr}}$	$I_F=30\text{A}, V_{\text{GS}}=0\text{V}, \text{di}/\text{dt}=100\text{A}/\mu\text{s}$		44		ns
Body Diode Reverse Recovery Charge	$Q_{\text{rr}}$			74		nC

Notes: 1. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ .

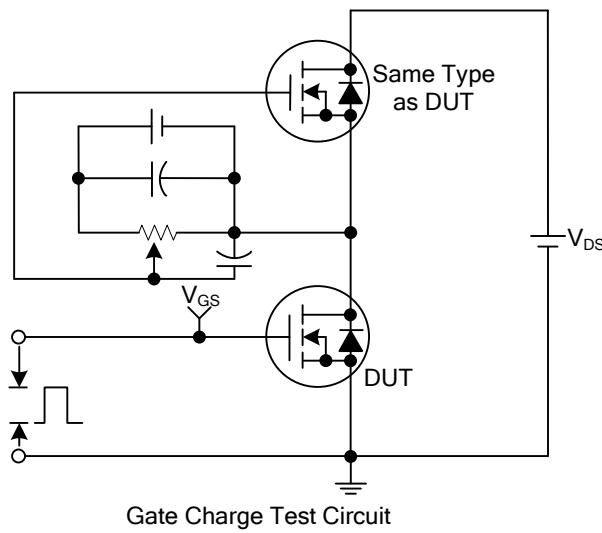
2. Essentially independent of operating ambient temperature.

■ TEST CIRCUITS AND WAVEFORMS

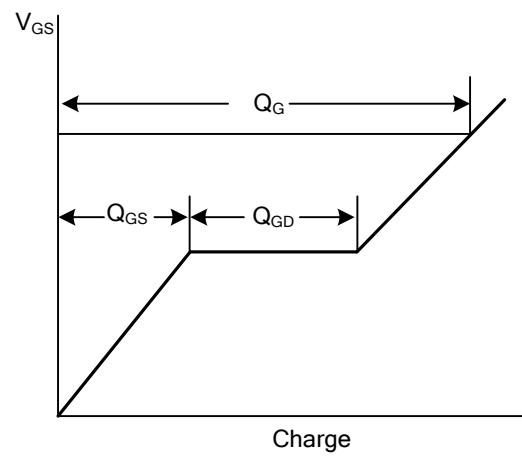


Peak Diode Recovery  $dv/dt$  Test Circuit and Waveforms

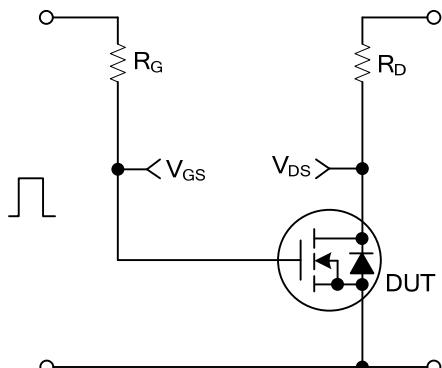
■ TEST CIRCUITS AND WAVEFORMS



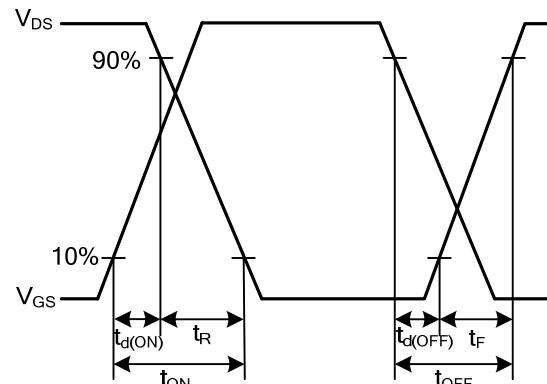
Gate Charge Test Circuit



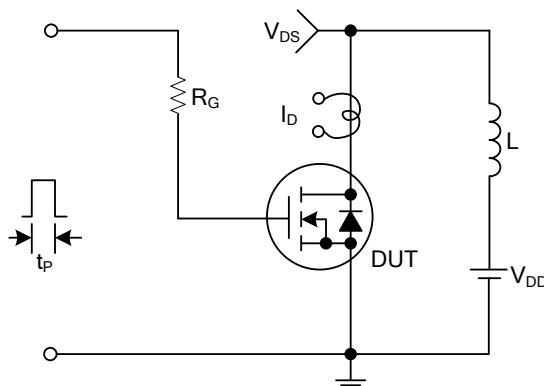
Gate Charge Waveforms



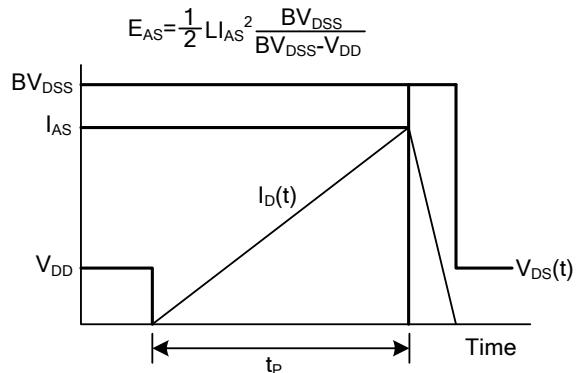
Resistive Switching Test Circuit



Resistive Switching Waveforms

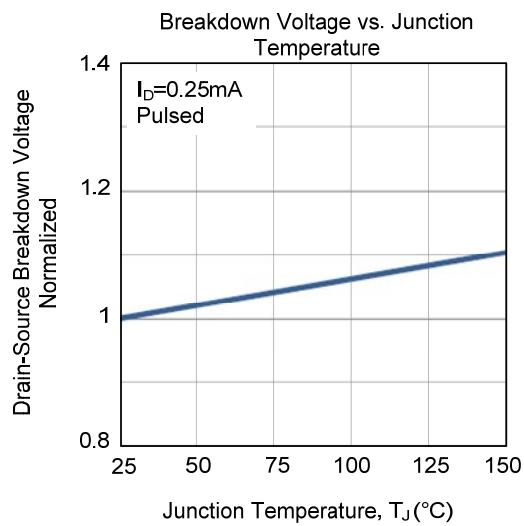
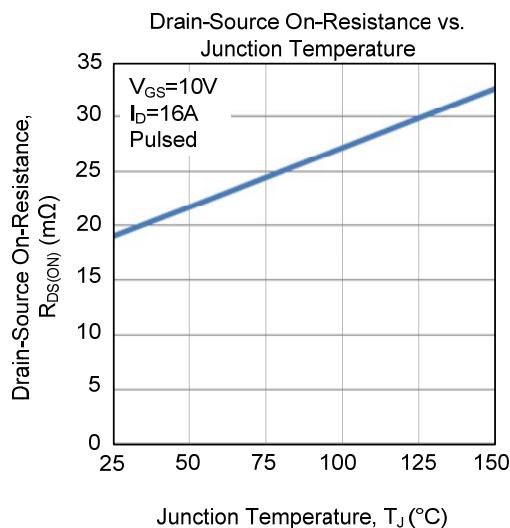
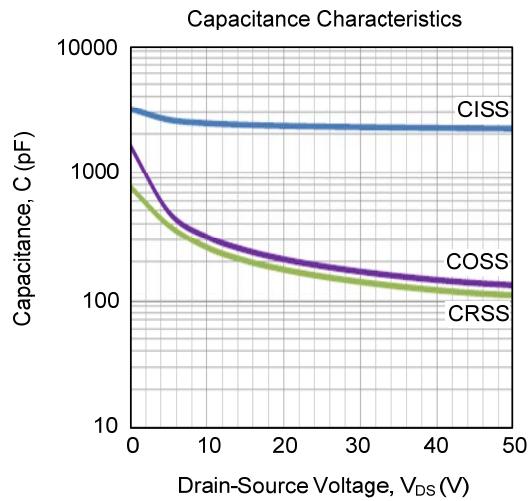
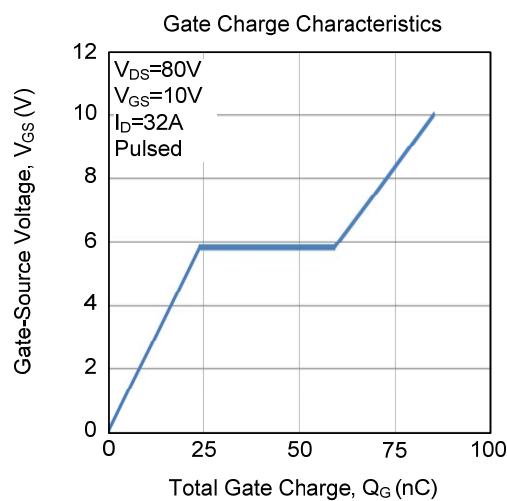
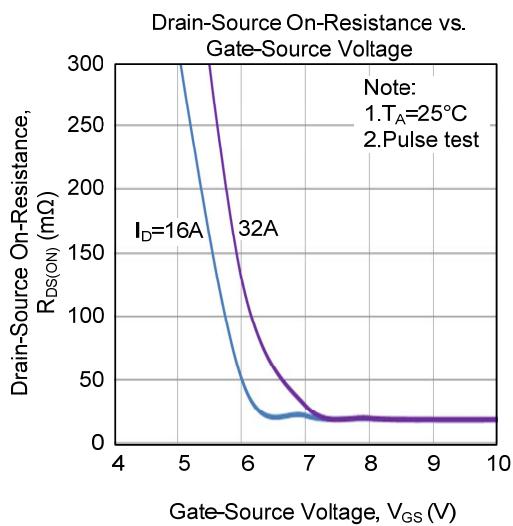
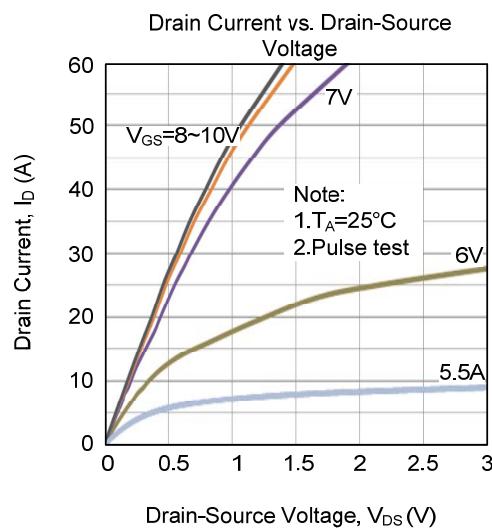


Unclamped Inductive Switching Test Circuit

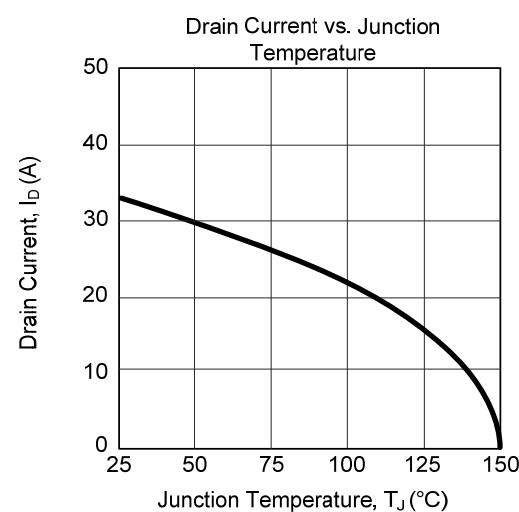
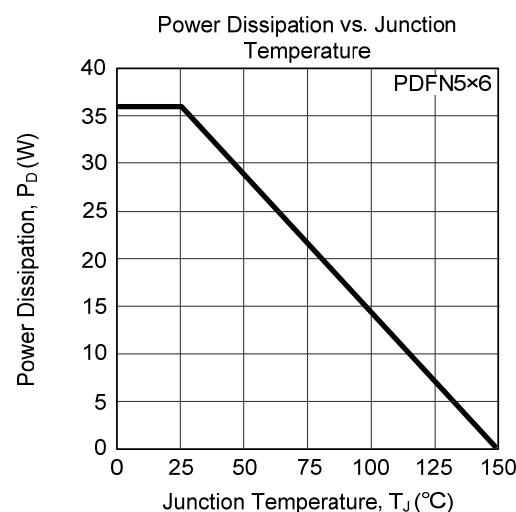
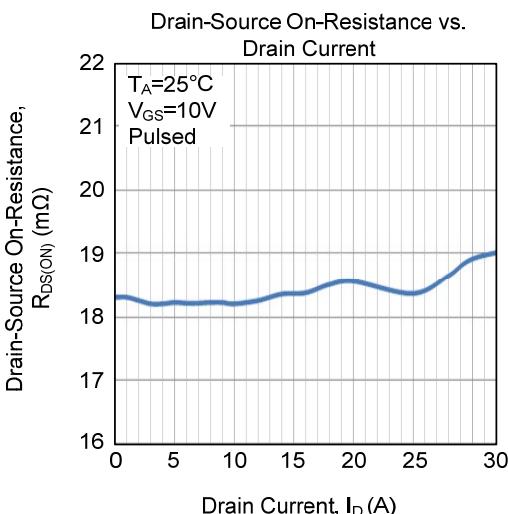
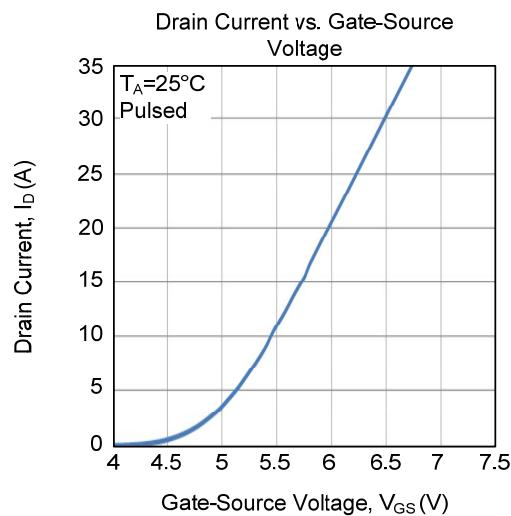
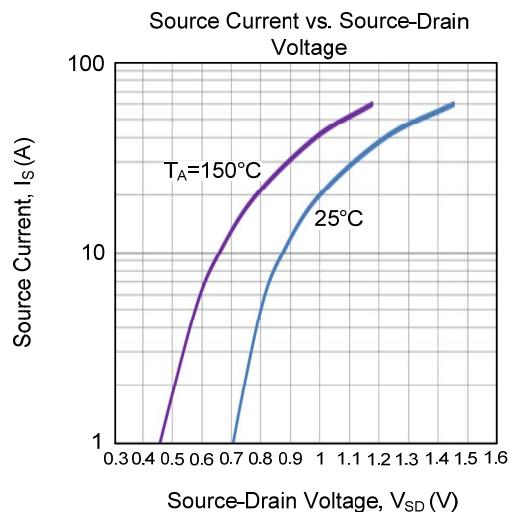
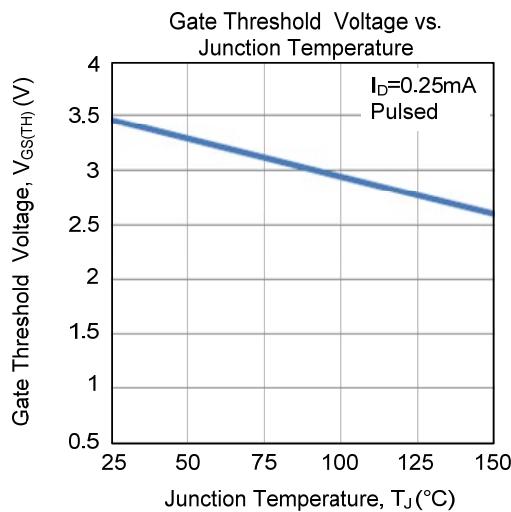


Unclamped Inductive Switching Waveforms

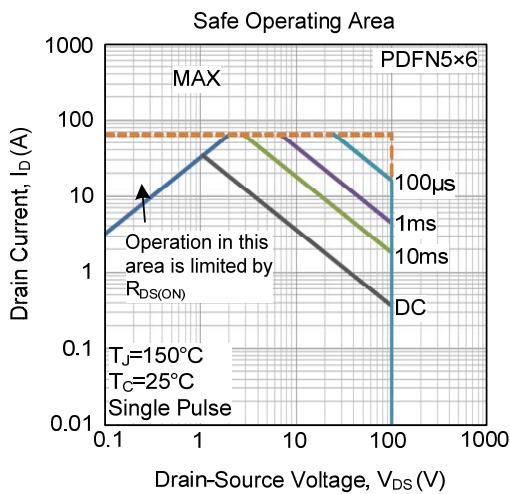
■ TYPICAL CHARACTERISTICS



## ■ TYPICAL CHARACTERISTICS (Cont.)



## ■ TYPICAL CHARACTERISTICS (Cont.)



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